

## Static Differential Hall Effect Sensor IC

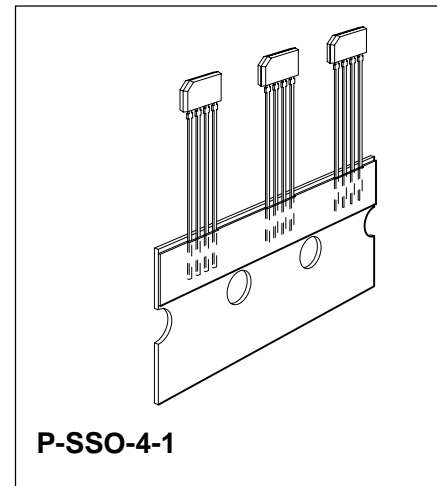
**TLE 4974**

**Preliminary Data**

**Bipolar IC**

### Features

- Static operation (zero speed)
- Digital output signal
- Two-wire and three-wire configuration possible
- Large temperature range
- Protection against overvoltage
- Protection against reversed polarity
- Output protection against electrical disturbances



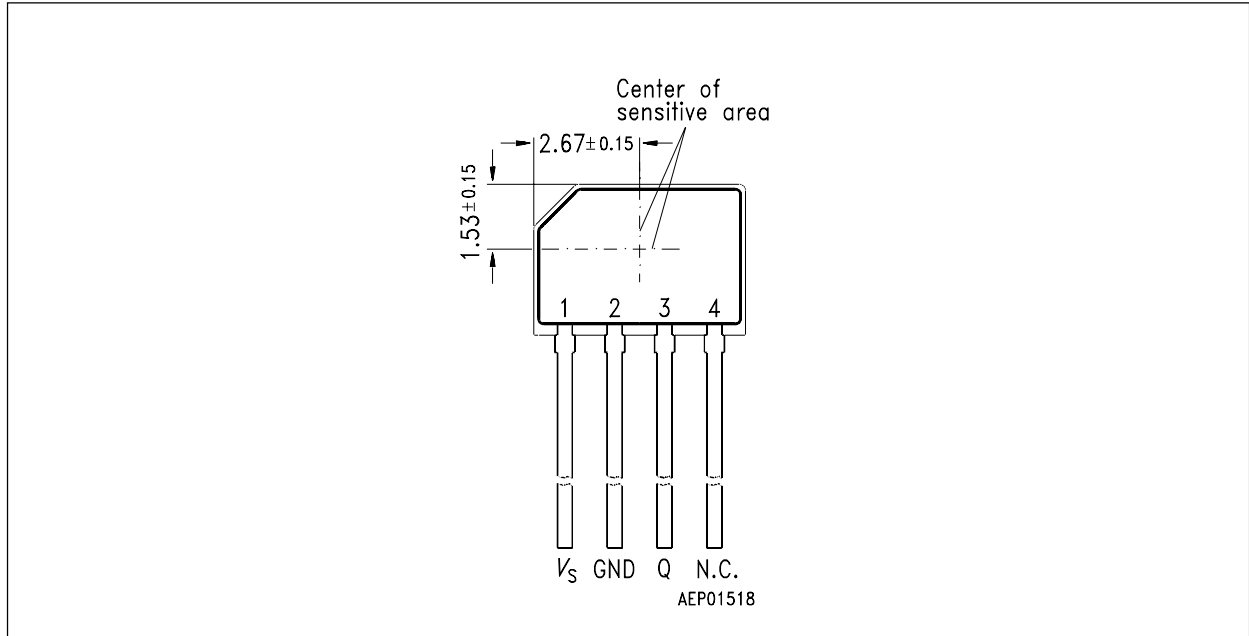
Type	Ordering Code	Package
TLE 4974 U	Q67006-A9133	P-SSO-4-1

The TLE 4974 U is a differential Hall effect sensor designed for rotational speed and timing applications using ferromagnetic toothed wheels and slotted shafts such as camshafts, crankshafts, transmissions, and ABS/TCS systems.

Since the TLE 4974 U can detect zero rotation speed, it is applicable to position sensing as well.

The TLE 4974 U provides a digital signal output with frequency proportional to the speed of rotation. Unlike other rotational sensors differential Hall ICs are not influenced by radial vibration within the effective airgap of the sensor and require no external signal processing.

## Pin Configuration (top view)



## Pin Definitions and Functions

Pin	Symbol	Function
1	$V_S$	Supply voltage
2	GND	Ground
3	Q	Output
4	N.C.	Not connected

## Functional Description

The differential Hall sensor IC detects the motion of, and static position of, ferromagnetic and permanent magnet structures by measuring the differential flux density of the magnetic field. To detect ferromagnetic objects the magnetic field must be provided by a back biasing permanent magnet (a magnet attached to the back, unmarked, side of the IC package).

## Circuit Description (see Figure 1 and 2)

The TLE 4974 U is comprised of a supply voltage reference, a pair of Hall probes spaced at 2.5 mm, differential amplifier, Schmitt trigger, an open collector output.

Protection is provided at the input/supply (pin 1) for overvoltage and reverse polarity and against overstress such as load dump, etc., in accordance with ISO-TR 7637 and DIN 40839. The output (pin 3) is protected against voltage peaks and electrical disturbances.

## Operation

For ease of explanation the probes will be referred to as sensor 1 and sensor 2, and assumes that the Hall IC is back-biased using the south (positive) pole. Operation is reversed, with respect to the active sensor, if back-biasing uses the north (negative) pole.

Applications using a, front (marked side of the IC package) passing, magnet wheel is identical with respect to the Hall sensor operation. Please refer to **figure 9** System Operation.

As a magnetic source, or target pass in front of sensor 2 the magnetic field or field density creates a positive differential at the input of the differential amplifier, resulting in a proportional output to the Schmitt trigger, and a triggered output to the open collector driver.

When the source or target pass in front of sensor 1 (both probes are now influenced by the source/target) the amplifier inputs are in zero differential state and the output remains "on".

As the source or target move past sensor 2 (sensor 1 active) the amplifier inputs are in a negative differential state and the Schmitt trigger remains in the "off" state.

When the source or target moves past probe 1 (both probes not influenced by source/target) the amplifier is again in the zero differential state and the output remains in "off" condition, and the cycle repeats.

## Rotation Sensing Cycle

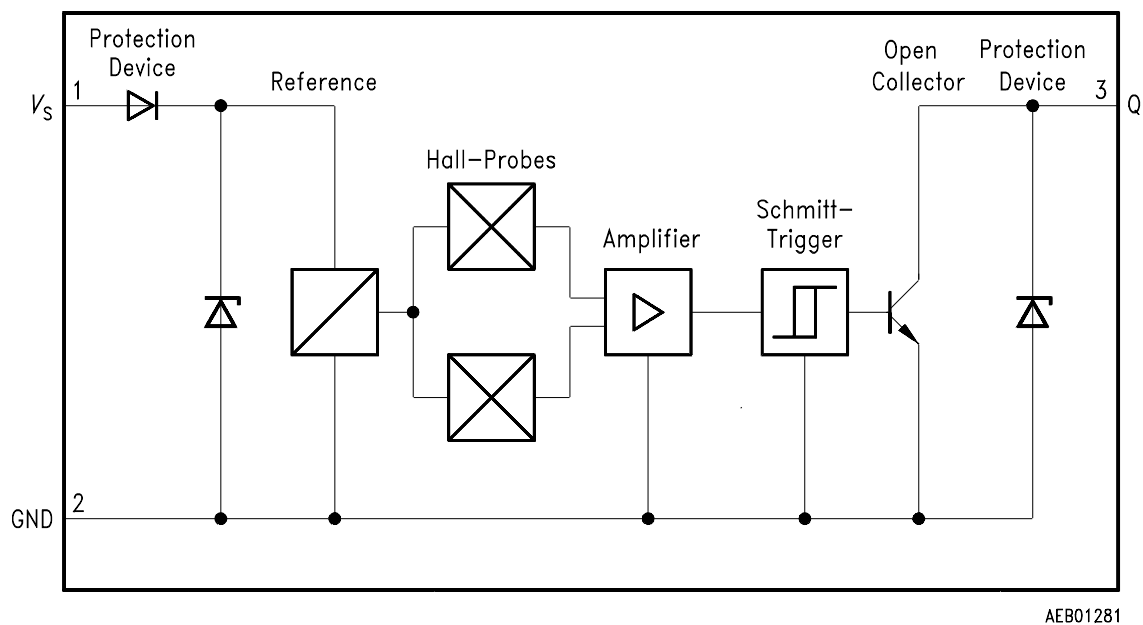
1. Sensor 2 active (over target) - Output triggered "on"
2. Sensor 1 and 2 active (both probes over target) - Output remains "on".

### **Note:**

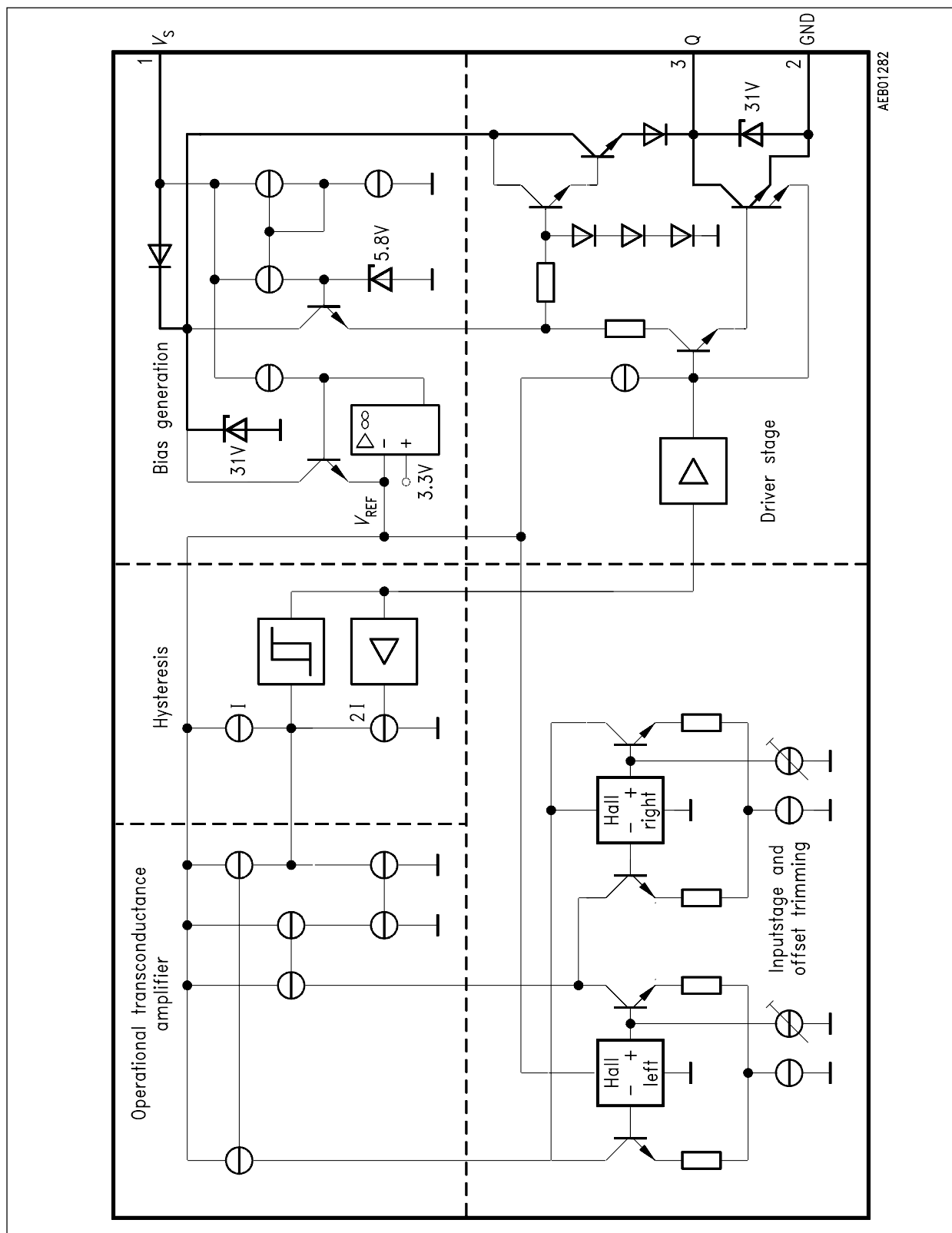
This is not guaranteed over temperature.

3. Sensor 2 inactive (over space), sensor 1 active (over target) - Negative differential mode - Output triggered "off".
4. Sensor 1 and 2 inactive (both probes over space) - Output remains "off".

For applications which require larger airgaps (3 mm +) and do not require zero (static) speed sensing, the TLE 4921-2U (dynamic-active high output) should be used.



**Figure 1**  
**Block Diagram 1**



**Figure 2**  
**Block Diagram 2**

## Absolute Maximum Ratings

$T_j = -40$  to  $150$  °C

Parameter	Symbol	Limit Values		Unit	Remarks
		min.	max.		
Supply voltage	$V_S$	-40	30	V	–
Output voltage	$V_Q$	-0.7	30	V	–
Output current	$I_Q$	–	50	mA	–
Output reverse current	$-I_Q$	–	50	mA	–
Junction temperature	$T_j$	–	150	°C	–
Junction temperature	$T_j$	–	170	°C	1000 h
Junction temperature	$T_j$	–	210	°C	40 h
Storage temperature	$T_{stg}$	-40	150	°C	–
Thermal resistance	$R_{th JA}$	–	190	K/W	–
Current through input-protection device	$I_{SZ}$	–	200	mA	$t < 2$ ms; $v = 0.1$
Current through output-protection device	$I_{QZ}$	-200	200	mA	$t < 2$ ms; $v = 0.1$

## Electro Magnetic Compatibility

ref. DIN 40839 part 1; test circuit 1

Testpulse 1	$V_{LD}$	-100	–	V	$t_d = 2$ ms
Testpulse 2	$V_{LD}$	–	100	V	$t_d = 0.05$ ms
Testpulse 3a	$V_{LD}$	-150	–	V	$t_d = 0.1$ µs
Testpulse 3b	$V_{LD}$	–	100	V	$t_d = 0.1$ µs
Testpulse 4	$V_{LD}$	-7	–	V	$t_d \leq 20$ s
Testpulse 5	$V_{LD}$	–	120	V	$t_d = 400$ ms; $R_p = 450$ Ω

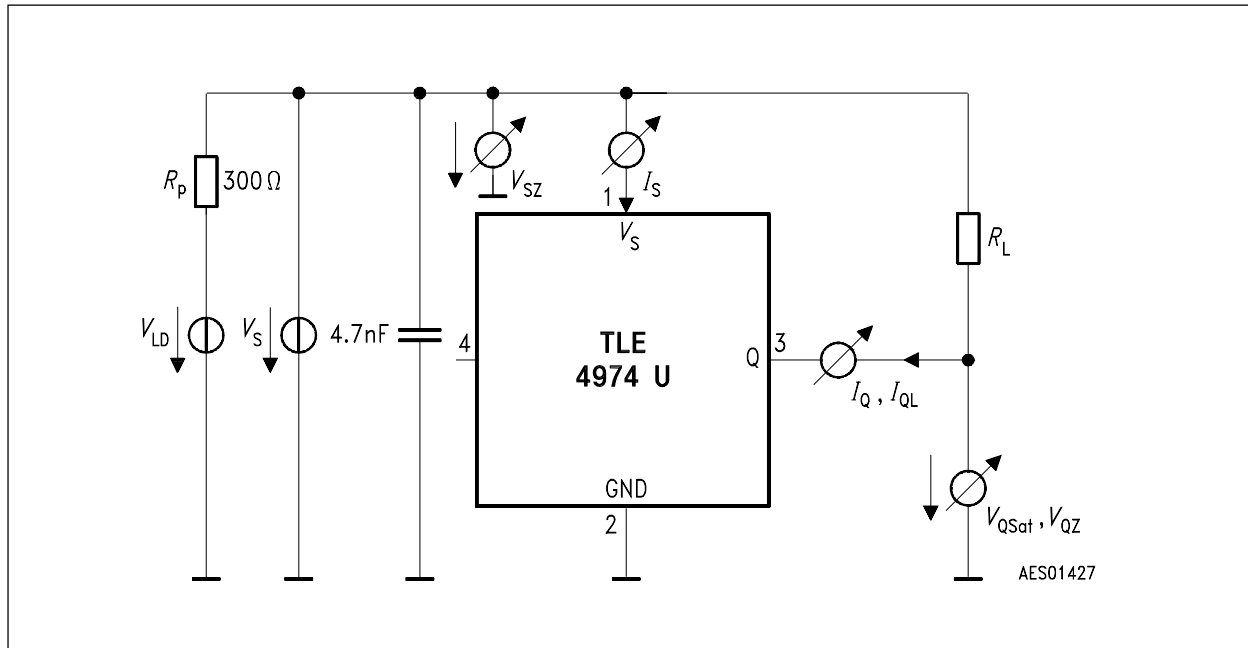
## Operating Range

Supply voltage	$V_S$	4.5	24	V	–
Junction temperature	$T_j$	-40	150	°C	–
Junction temperature	$T_j$	-40	170	°C	threshold may exceed the limits
Pre-induction	$B_O$	-500	500	mT	–

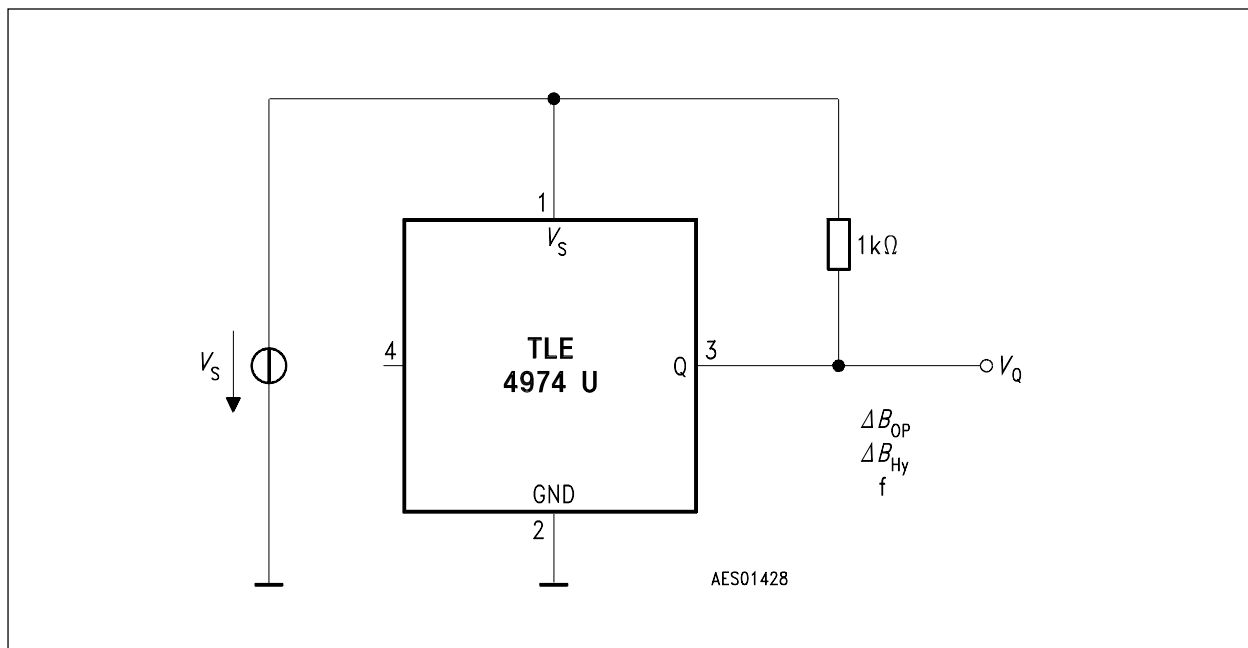
### AC/DC Characteristics

$4.5 \text{ V} \leq V_S \leq 24 \text{ V}$ ;  $-40 \text{ }^\circ\text{C} \leq T_j \leq 150 \text{ }^\circ\text{C}$

Parameter	Symbol	Limit Values			Unit	Test Condition	Test Circuit
		min.	typ.	max.			
Supply current	$I_S$	3.0	8	12	mA	$V_Q = \text{high}, I_Q = 0 \text{ mA}$	1
	$I_S$	3.5	8.5	13.5	mA	$V_S = 4.5 \text{ V}$	1
						$V_S \geq 7 \text{ V}$	
	$I_S$	3.5	8.5	12.5	mA	$V_Q = \text{low}, I_Q = 40 \text{ mA}$	1
	$I_S$	4.0	9	14.5	mA	$V_S = 4.5 \text{ V}$	1
						$V_S \geq 7 \text{ V}$	1
Output saturation voltage	$V_{Q\text{Sat}}$	–	0.25	0.6	V	$I_Q = 40 \text{ mA}$	1
Output leakage current	$I_{QL}$	–	–	10	$\mu\text{A}$	$V_Q = 24 \text{ V}$	1
Switching frequency	$f$	0	–	20	kHz	$\Delta B = 20 \text{ mT}$	2
Switching flux density	$\Delta B_{OP}$	– 6	2.5	17	mT	–	2
Hysteresis	$\Delta B_{Hy}$	3	5	10	mT	–	2
Overvoltage protection							
– at supply voltage	$V_{SZ}$	27	–	35	V	$I_S = 16 \text{ mA}$	1
– at output	$V_{QZ}$	27	–	35	V	$I_S = 16 \text{ mA}$	1



**Figure 3**  
**Test Circuit 1**



**Figure 4**  
**Test Circuit 2**

- $B_O = 100 \text{ mT}$ ;
- tooth wheel with module  $m = 2 \text{ mm}$
- Distance IC-object  $L = 1 \text{ mm}$
- Southpole at back of IC



## Application Notes

Two possible applications are shown in **figure 7 and 8** (Tooth and Magnet Wheel).

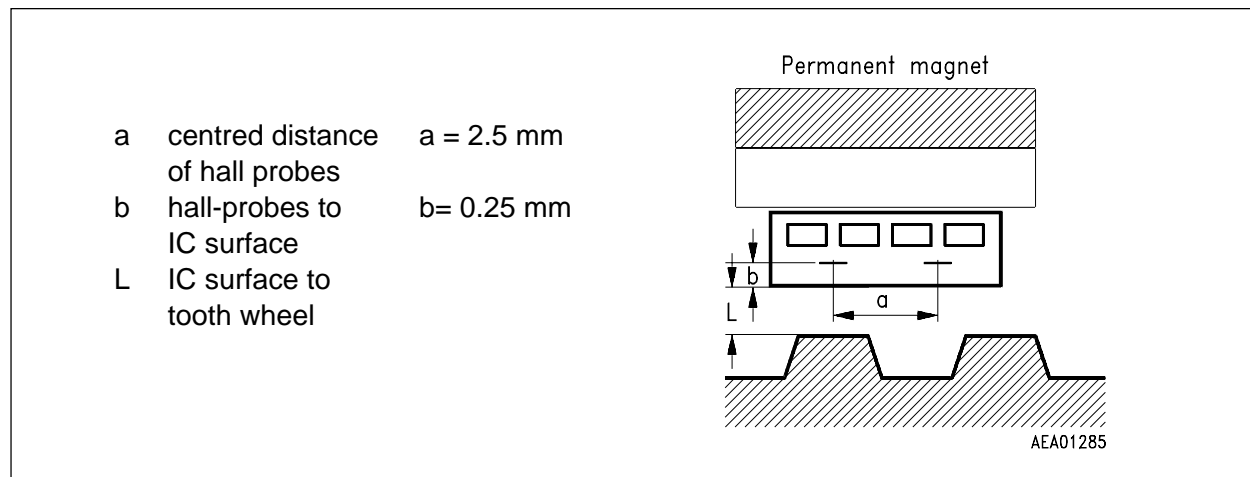
The differences between two-wire and three-wire application is shown in **figure 10**.

## Toothed Wheel Sensing

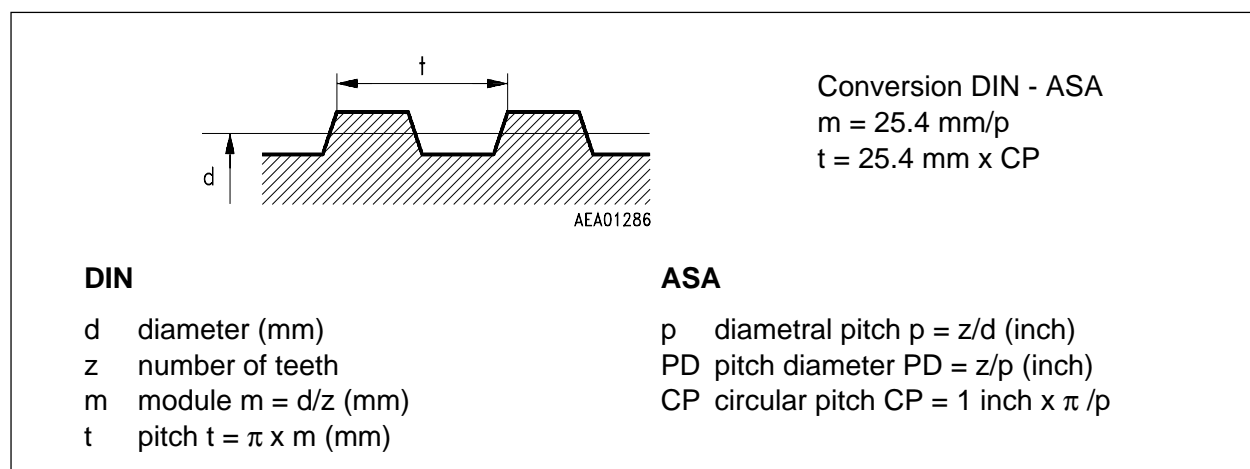
In the case of ferromagnetic toothed wheel application the IC has to be biased by a permanent magnet (e.g.  $\text{SECo}_5$  (Vacuumschmelze VX145) with the dimensions 8 mm x 5 mm x 3 mm) which should cover both hallprobes.

The maximum air gap depends on

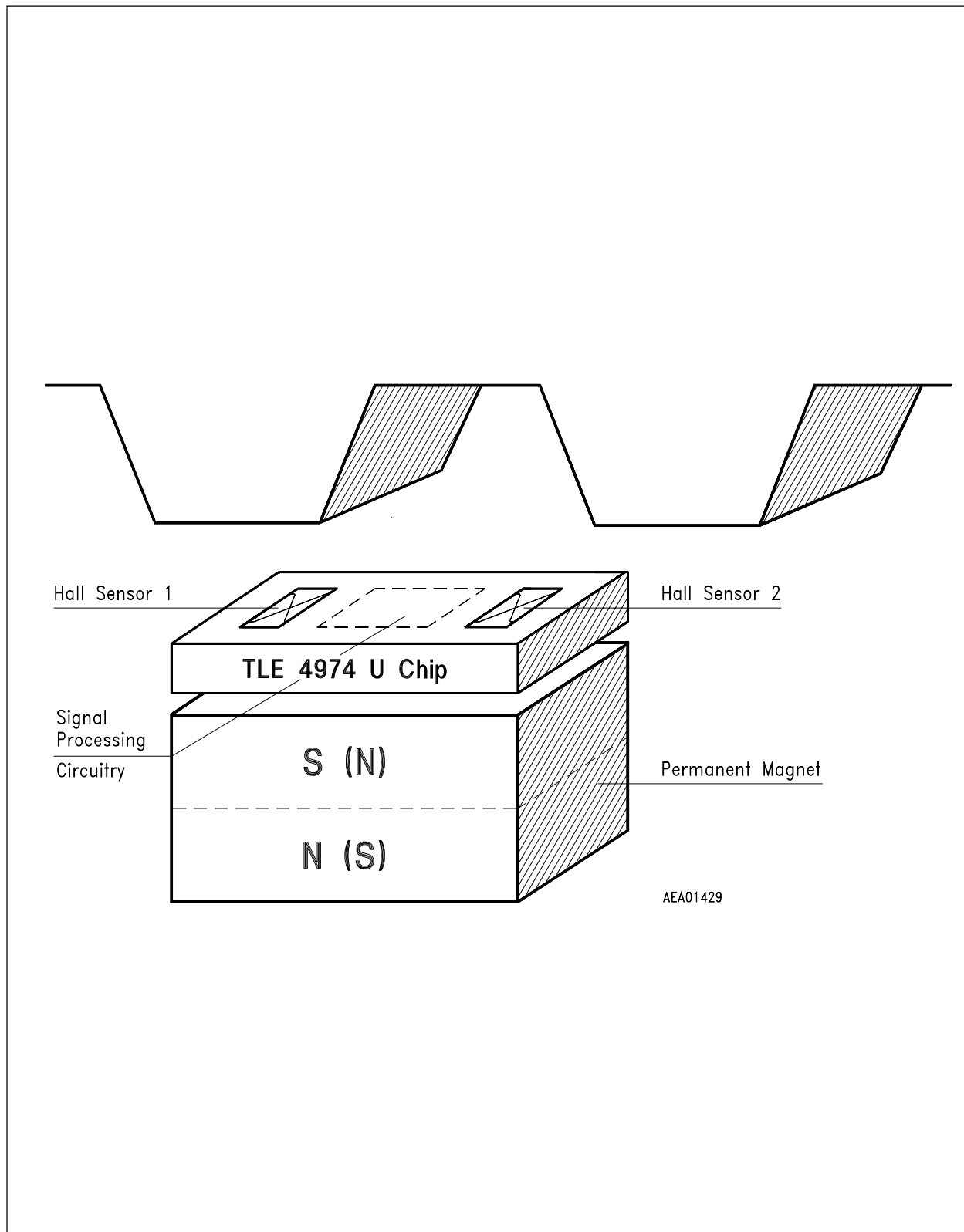
- the magnetic field strength (magnet used),
- the toothed wheel that is used (dimensions, material, etc),
- the ambient temperature



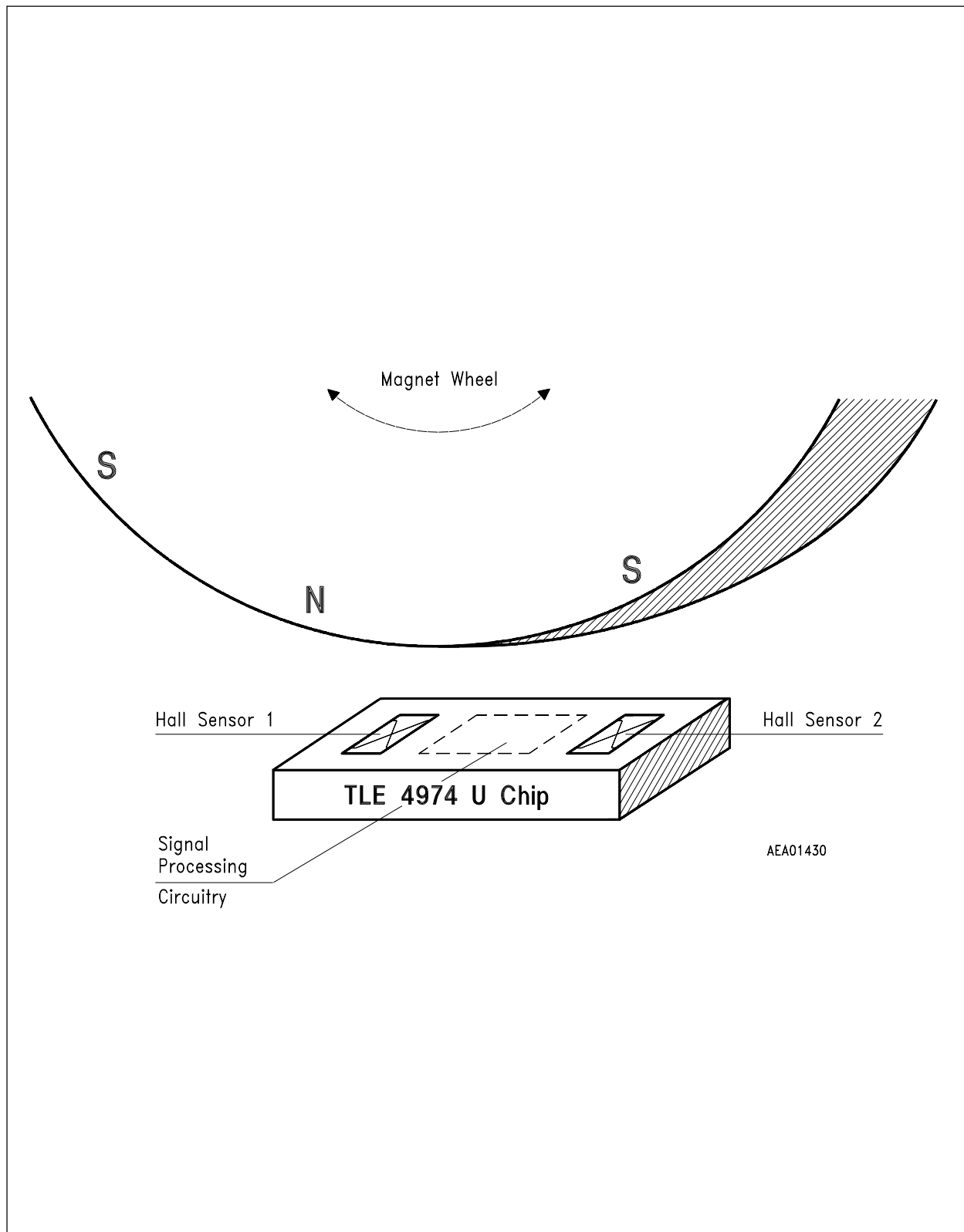
**Figure 5**  
**Sensor Spacing**



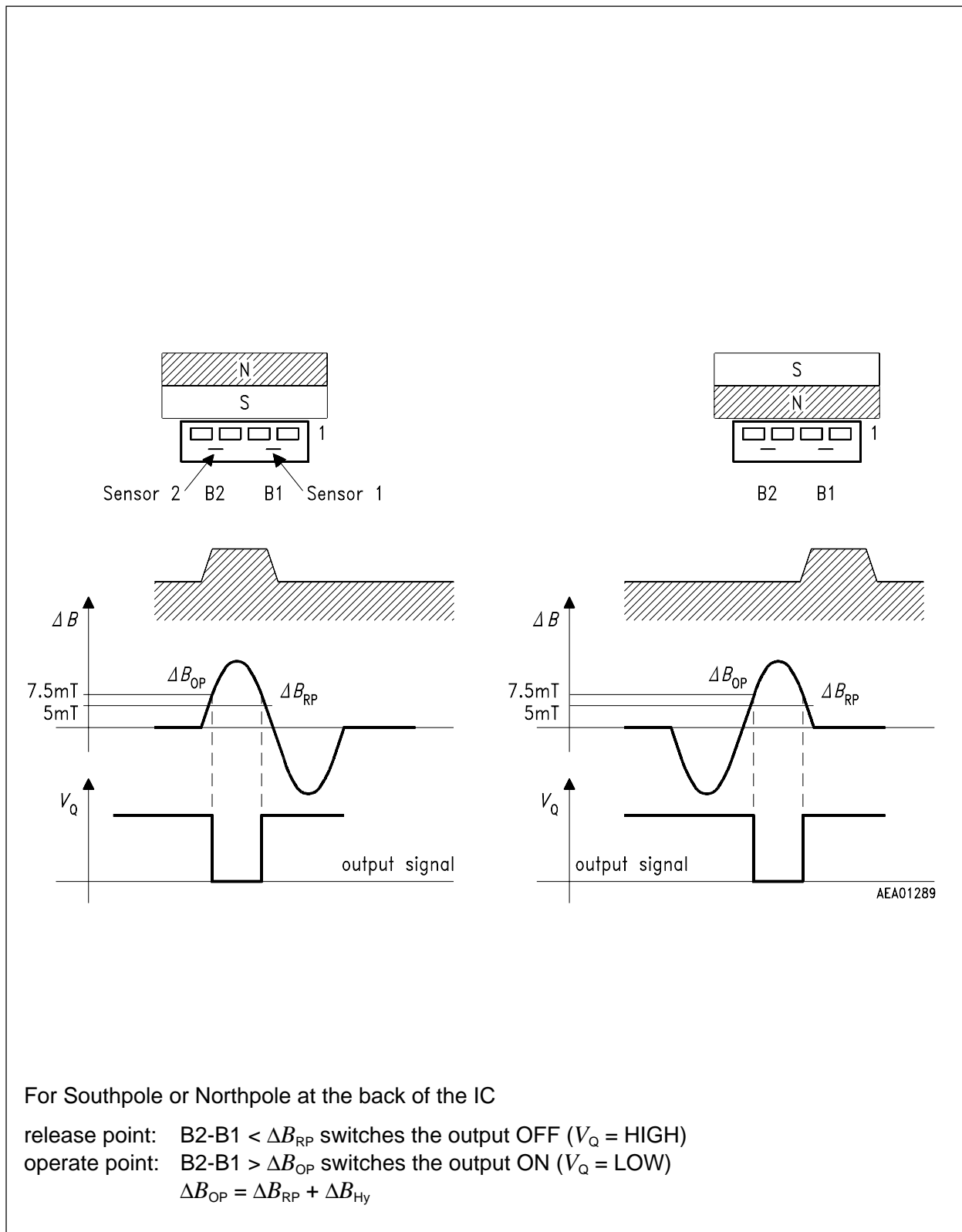
**Figure 6**  
**Toothed Wheel Dimensions**



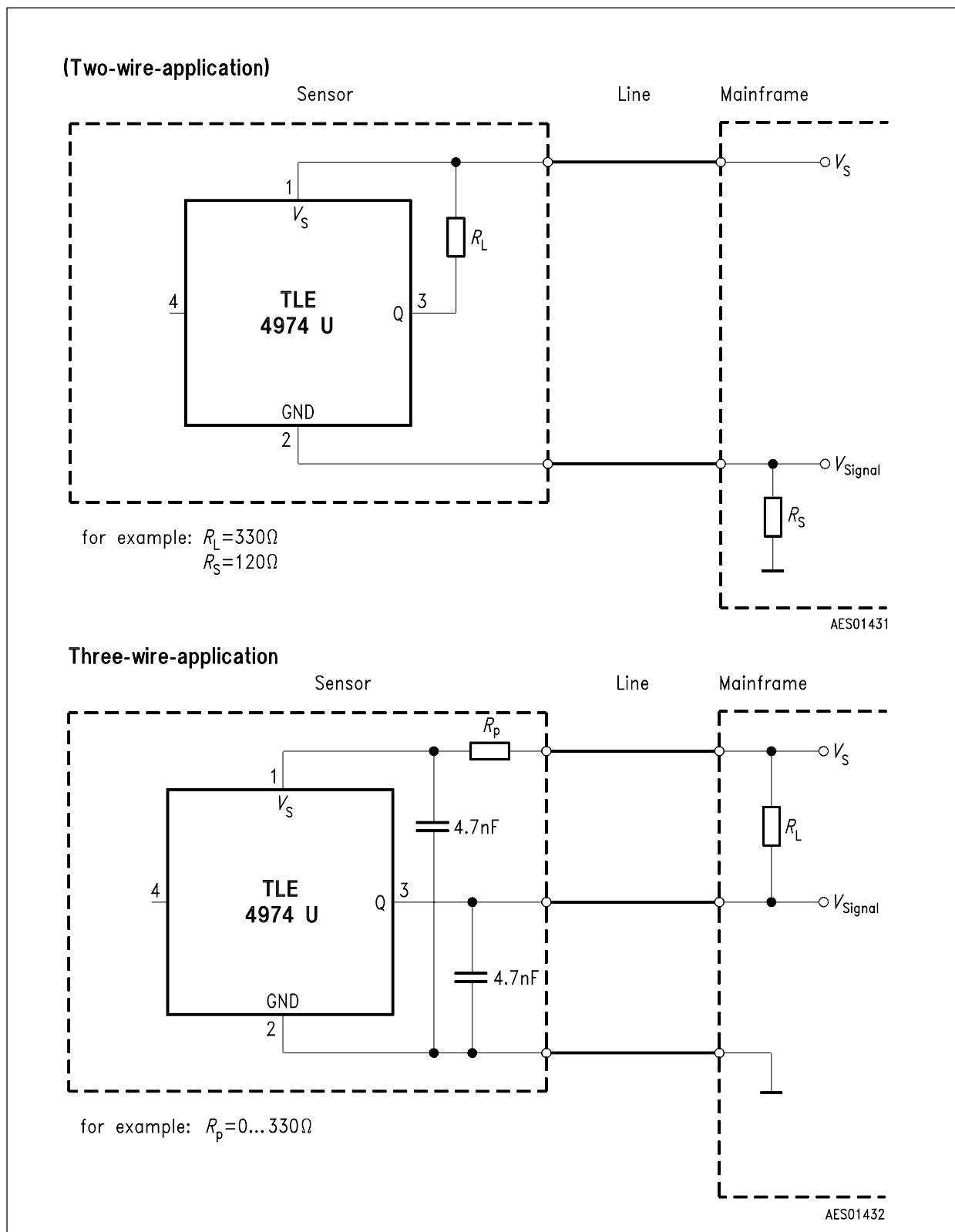
**Figure 7**  
TLE 4974 U, with Ferromagnetic Toothed Wheel



**Figure 8**  
**TLE 4974 U, with Magnet Wheel**

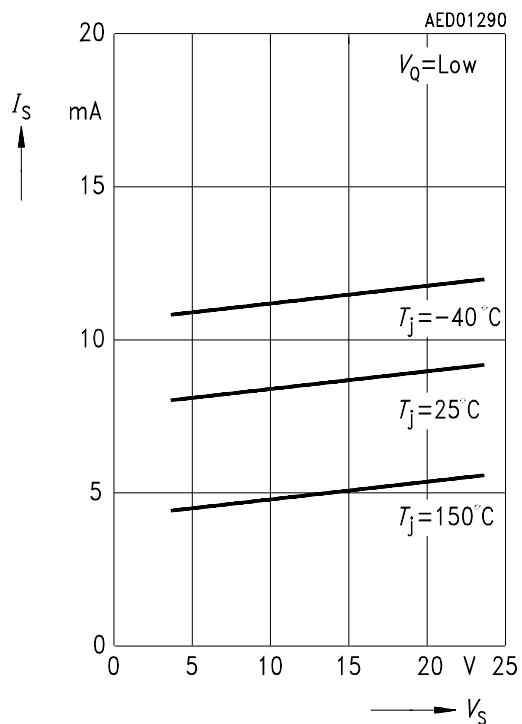


**Figure 9**  
**System Operation**

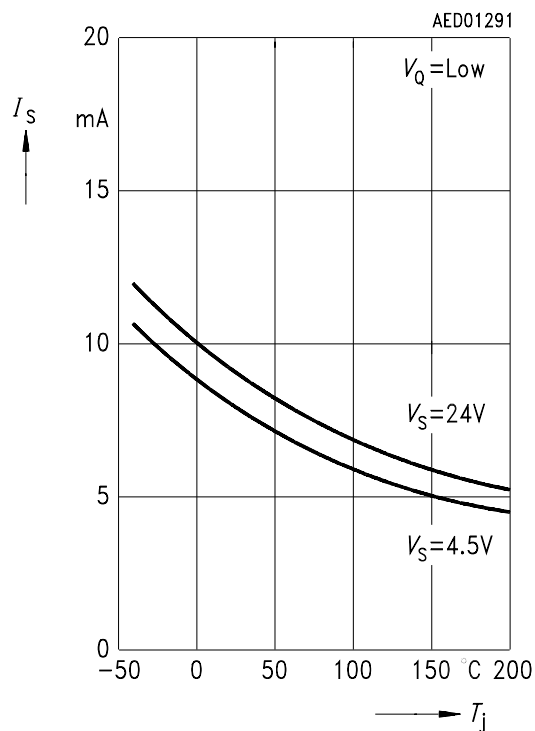


**Figure 10**  
**Application Circuits**

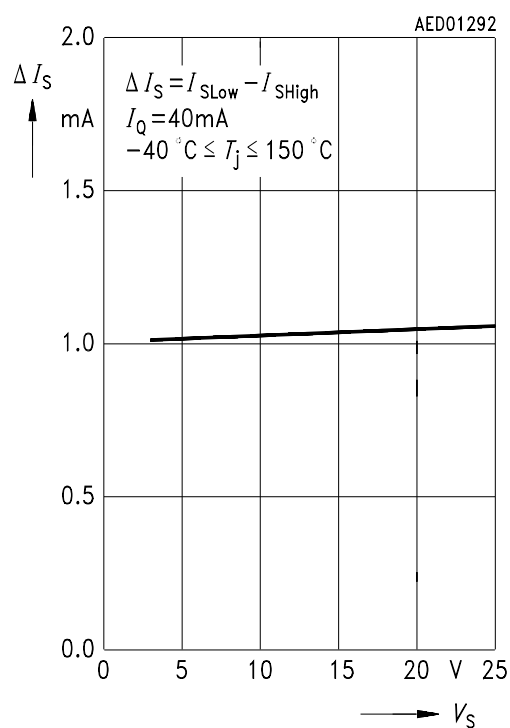
### Quiescent Current versus Supply Voltage



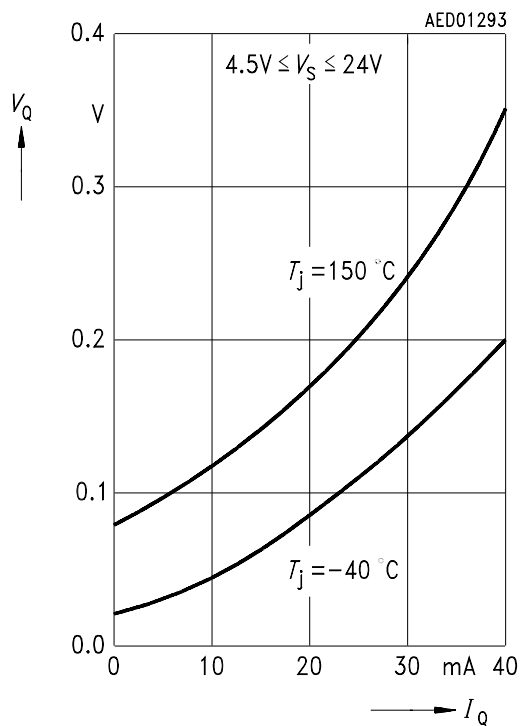
### Quiescent Current versus Junction Temperature



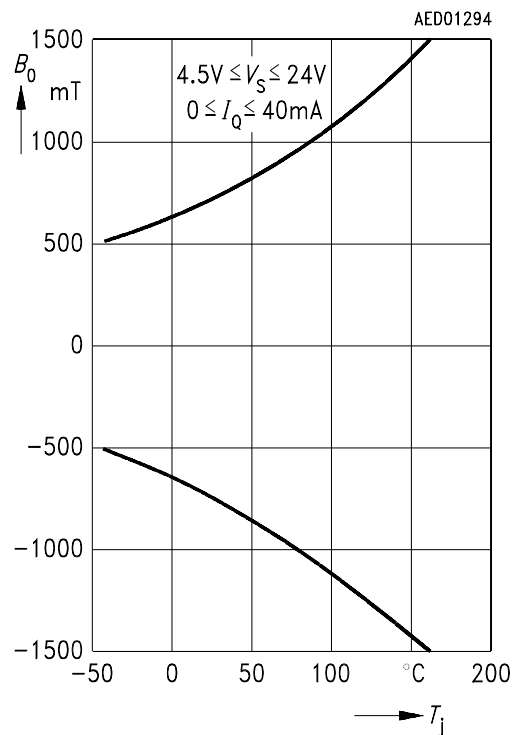
### Quiescent Current Difference versus Supply Voltage



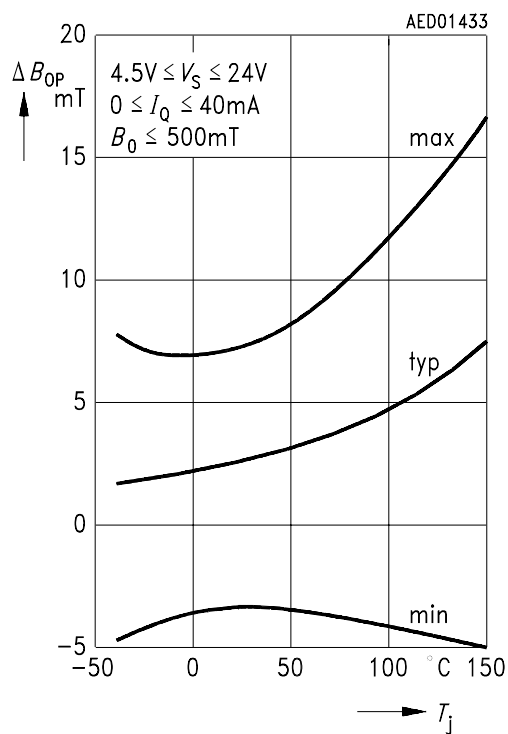
### Saturation Voltage versus Output current



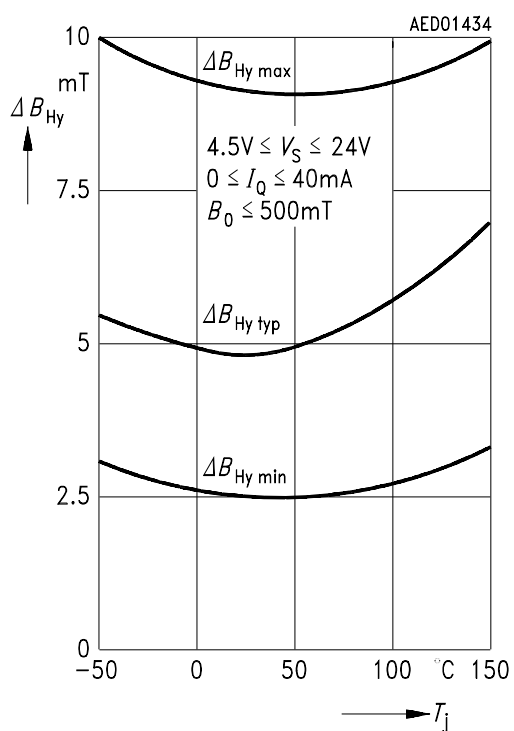
**Maximum Preinduction versus Junction Temperature**



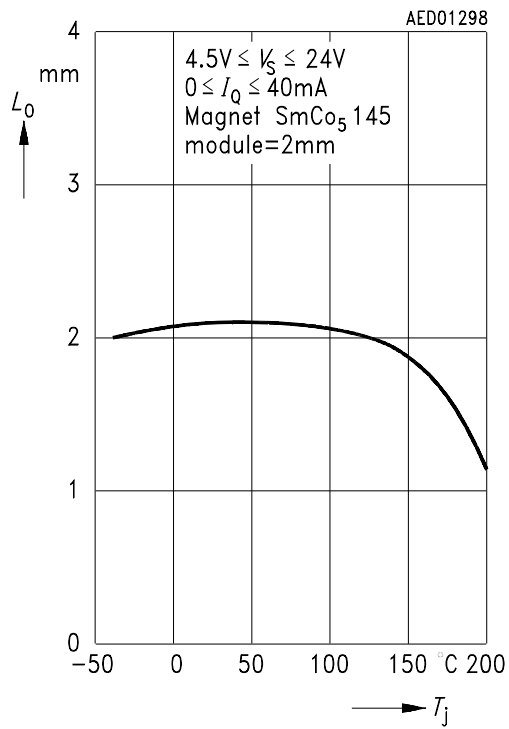
**Switching Induction versus Temperature**



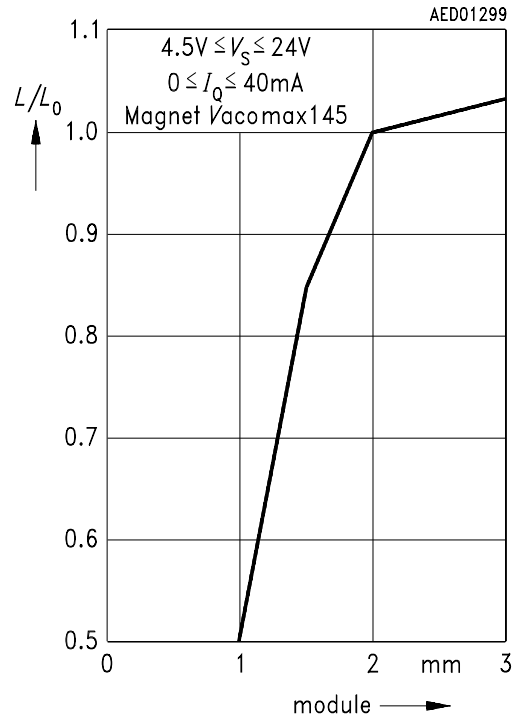
**Hysteresis Induction versus Junction Temperature**



### Distance IC-Toothed Wheel versus Junction Temperature



### Relative Distance versus Module



### Fall and Rise Time versus Junction Temperature

